Study on Latent Representation and Clustering

Kyeong Ryeol, Go M.S. Candidate of OSI Lab

Explicit distribution

- 1. Disentanglement
 - 1. Beta-VAE
 - 2. Factor-VAE
 - 3. Beta-TC-VAE
 - 4. HSIC-constrained-VAE

Factors of variation이 latent space의 axis로 각각 align되도록 함.

- i) 기존의 ELBO에 penalty term을 추가하거나,
- ii) 기존의 ELBO를 decompose해서 특정 component의 weight를 세게 주는 방식이 있다.
- 2. Gaussian Mixture Model
 - 1. Variational Deep Embedding (VaDE)
 - 2. Gaussian Mixture VAE (GM-VAE)
- 3. Dirichlet Mixture Model
 - 1. Stick Breaking VAE (SB-VAE)
 - 2. Dirichlet VAE (Dir-VAE)
- 4. Flow-based
 - 1. Normalizing Flows (NF)
 - 2. Inverse Autoregressive Flows (IAF)

Disentanglement

- Beta-VAE
 - $\mathbb{E}_{q_{\phi}(z|x)}[\log p_{\theta}(x|z)] \beta \cdot KL(q_{\phi}(z|x)||p(z))$
 - $\beta = 1 \rightarrow original\ ELBO$
- 2. Factor-VAE
 - $\mathbb{E}_{q_{\phi}(z|x)}[\log p_{\theta}(x|z)] \beta \cdot KL\left(q_{\phi}(z) \left\| \prod_{d} q_{\phi}(z_{d}) \right) KL(q_{\phi}(z|x)||p(z))\right)$ $(q_{\phi}(z) = E_{p(x)}[q_{\phi}(z|x)])$
 - $KL\left(q_{\phi}(z) \left\| \prod_{d} q_{\phi}(z_{d}) \right) \approx E_{q_{\phi}(z)} \left[\log \frac{D(z)}{1 D(z)} \right]$ where D is a discriminator $: q_{\phi}(z)$ v.s. $\prod_{d} q_{\phi}(z_{d})$ (Inner optimization loop exists)
 - $\beta = 0 \rightarrow original\ ELBO$

Disentanglement

- Beta-TC-VAE
 - $\mathbb{E}_{q_{\phi}(z|x)}[\log p_{\theta}(x|z)] \beta \cdot KL\left(q_{\phi}(z) \left\| \prod_{d} q_{\phi}(z_{d}) \right) KL\left(q_{\phi}(z,x) \left\| q_{\phi}(z)p(x) \right) \sum_{d} KL\left(q_{\phi}(z_{d}) \left\| p(z_{d}) \right\| \right) \right)$
 - $KL\left(q_{\phi}(z) \middle| \prod_{d} q_{\phi}(z_{d})\right) = E_{q_{\phi}(z)}\left[\log q_{\phi}(z)\right] E_{q_{\phi}(z)}\left[\log \prod_{d} q_{\phi}(z_{d})\right]$
 - $E_{q_{\phi}(z)}[\log q_{\phi}(z)] \approx \frac{1}{M} \sum_{i=1}^{M} \log \sum_{j=1}^{M} \exp(\log \sum_{d} q_{\phi}(z_{d}^{i}|x^{j})) \log NM$
 - $E_{q_{\phi}(z)}[\log \prod_{d} q_{\phi}(z_{d})] = \sum_{d} E_{q_{\phi}(z_{d})}[\log q_{\phi}(z_{d})] \approx \sum_{d} \frac{1}{M} \sum_{i=1}^{M} \log \sum_{j=1}^{M} \exp(\log q_{\phi}(z_{d}^{i}|x^{j})) \log NM$
 - $\beta = 1 \rightarrow original ELBO$ (objective function can be identical to that of Factor-VAE)
- 4. HSIC-constrained-VAE
 - $\mathbb{E}_{q_{\phi}(z|x)}[\log p_{\theta}(x|z)] \beta \cdot HSIC(q_{\phi}(z)) KL(q_{\phi}(z|x)||p(z))$
 - $\beta = 0 \rightarrow original\ ELBO$

Measure between prob. dist. by kernel

- Hilbert-Schmidt Independence Criterion (HSIC)
 - \rightarrow Independence test: x and y independent? \rightarrow if yes, 0

•
$$H(p,q) = \|E_{x\sim p, y\sim q}[(f(x) - \mu_x) \otimes (g(y) - \mu_y)]\|_{HS}^2$$

 $= E_{x,x'\sim p, y,y'\sim q}[k(x,x')l(y,y')] + E_{x,x'\sim p}[k(x,x')]E_{y,y'\sim q}[l(y,y')] - 2E_{x,y}[E_{x'}[k(x,x')]E_{y,y}[l(y,y')]]$

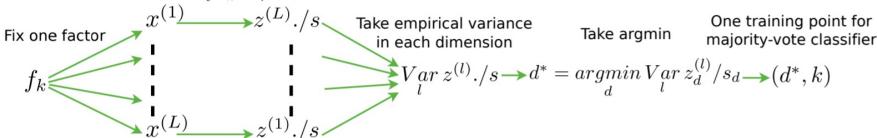
- Maximum Mean Discrepancy (MMD)
 - \rightarrow Two sample test: $\{x_i\} \sim p(x)$ and $\{y_i\} \sim q(y)$ from the same dist? \rightarrow if yes, 0
 - $M(p,q) = \max_{h \in H} \{E_{x \sim p}[h(x)] E_{y \sim q}[h(y)] \text{ s. t. } ||h||_{H} \le 1\}$ = $E_{x,x' \sim p, y,y' \sim q}[k(x,x') + k(y,y') - 2k(x,y')]$
- Kernelized Stein Discrepancy (KSD)
 - \rightarrow Goodness-of-fit test : $\{x_i\} \sim q(x)$ from p(x)? \rightarrow if yes, 0
 - $A_p f(x) := \nabla_x \log p(x) f(x)^T + \nabla_x f(x) \rightarrow E_{x \sim p} [A_p f(x)] = 0$ if f is in stein class of p
 - $K(q,p) = \max_{f \in H^d} \left\{ E_{x \sim q} \left[trace \left(A_p f(x) \right) \right] \text{ s. t. } ||f||_{H^d} \le 1 \right\}$ $= \left\| E_{x \sim q} \left[A_p k(\cdot, x) \right] \right\|_{H^d} \text{ where } f_{opt} = E_{x \sim q} \left[A_p k(\cdot, x) \right] / \left\| E_{x \sim q} \left[A_p k(\cdot, x) \right] \right\|_{H^d}$

Disentanglement measure

1. From Beta-VAE Generate data with C is C if C is one factor C in C

2. From Factor-VAE

Generate data with Get rescaled fixed f_k , random f_{-k} representation



- 3. From Beta-TC-VAE
 - Mutual Information Gap (MIG) = $\frac{1}{K} \sum_{k=1}^{K} \frac{1}{H(v_k)} \left(I_n \left(z_{j^{(k)}}; v_k \right) \max_{j \neq j^{(k)}} I_n \left(z_j; v_k \right) \right)$ where $j^k = argmax_j I_n(z_j; v_k)$, $H(v_k) = E_{p(v_k)} [-\log p(v_k)]$ and $0 \leq I(z_j; v_k) \leq H(v_k)$

Explicit distribution

- 1. Disentanglement
 - 1. Beta-VAE
 - 2. Factor-VAE
 - 3. Beta-TC-VAE
 - 4. HSIC-constrained-VAE
- 2. Gaussian Mixture Model
 - 1. Variational Deep Embedding (VaDE)
 - 2. Gaussian Mixture VAE (GM-VAE)
- 3. Dirichlet Mixture Model
 - 1. Stick Breaking VAE (SB-VAE)
 - 2. Dirichlet VAE (Dir-VAE)
- 4. Flow-based
 - 1. Normalizing Flows (NF)
 - 2. Inverse Autoregressive Flows (IAF)

Gaussian Mixture Model

- Variational Deep Embedding (VaDE)
 - Joint distribution : $p_{\theta}(x,z,c) = p_{\theta}(x|z)p_{\theta}(z|c)p(c)$ $p_{\theta}(x|z) = Ber(x|\mu_{x}(z);\theta) \quad or \quad N(x|\mu_{x}(z),\sigma_{x}^{2}(z)I;\theta)$ $p(z|c) = N(z|\mu_{z}(c),\sigma_{z}^{2}(c)I)$ $p(c) = Cat(c|\pi)$
 - Variational distribution : $q_{\phi}(z, c|x) = q_{\phi}(z|x)q(c|x)$

$$q_{\phi}(z|x) = N(z|\tilde{\mu}_{z}(x), \tilde{\sigma}_{z}^{2}(x)I; \phi)$$

$$q(c|x) \approx p(c|z) = p(c)p(z|c) / \sum_{c'=1}^{K} p(c')p(z|c')$$

$$(\because L_{ELBO}(X) = E_{q_{\phi}(z|x)}[\log p_{\theta}(x|z)] - KL(q_{\phi}(z|x)||p(z)) - KL(q(c|x)||p(c|z))])$$

• ELBO
$$\begin{split} L_{ELBO}(x) &= E_{q_{\phi}(Z,\,C|\mathcal{X})} \big[\log p(x,z,c) - \log q_{\phi}(z,c|x)\big] \\ &= E_{q_{\phi}(z,c|x)} \big[\log p_{\theta}(x|z) + \log p(z|c) + \log p(c) - \log q_{\phi}(z|x) - \log q(c|x)\big] \end{split}$$

Gaussian Mixture Model

- Gaussian Mixture VAE (GM-VAE)
 - Joint distribution : $p_{\theta}(x, z, w, c) = p_{\theta}(x|z)p_{\theta}(z|w, c)p(w)p(c)$

$$p_{\theta}(x|z) = Ber(x|\mu_{x}(z);\theta) \quad or \quad N(x|\mu_{x}(z),\sigma_{x}^{2}(z)I;\theta)$$

$$p_{\theta}(z|w,c) = N(z|\mu_{z}(w,c),\sigma_{z}^{2}(w,c)I;\theta)$$

$$p(w) = N(w|0,I)$$

$$p(c) = Cat(c|\pi)$$

• Variational distribution : $q_{\phi}(z, c, w|x) = q_{\phi}(z|x)q_{\phi}(w|x)q(c|z, w)$

$$q_{\phi}(z|x) = N(z|\tilde{\mu}_{z}(x), \tilde{\sigma}_{z}^{2}(x)I; \phi)$$

$$q_{\phi}(w|x) = N(z|\hat{\mu}_{w}(x), \hat{\sigma}_{w}^{2}(x)I; \phi)$$

$$q(c|z, w) \approx p_{\theta}(c|z, w) = p(c)p_{\theta}(z|w, c) / \sum_{c'=1}^{K} p(c')p_{\theta}(z|w, c')$$

ELBO

$$\begin{split} L_{ELBO}(x) &= E_{q_{\phi}(Z,\,C,\,W|\mathcal{X})} \big[\log p_{\theta}(x,z,w,c) - \log q_{\phi}(z,c,w|x) \big] \\ &= E_{q_{\phi}(z|x)} \big[\log p_{\theta}(x|z) \big] - E_{q_{\phi}(W|\mathcal{X})p_{\theta}(C|Z,\,W)} \big[KL \big(q_{\phi}(z|x) || p_{\theta}(z|w,c) \big) \big] \\ &- KL \big(q_{\phi}(w|x) || p(w) \big) - E_{q_{\phi}(Z|\mathcal{X})q_{\phi}(W|\mathcal{X})} \big[KL \big(p_{\theta}(c|z,w) || p(c) \big) \big] \end{split}$$

Explicit distribution

- 1. Disentanglement
 - 1. Beta-VAE
 - 2. Factor-VAE
 - 3. Beta-TC-VAE
 - 4. HSIC-constrained-VAE
- 2. Gaussian Mixture Model
 - 1. Variational Deep Embedding (VaDE)
 - 2. Gaussian Mixture VAE (GM-VAE)
- 3. Dirichlet Mixture Model
 - 1. Stick Breaking VAE (SB-VAE) → introduce stochastic width, resolve decoder weight collapsing
 - 2. Dirichlet VAE (Dir-VAE) → appropriate for multimodal posterior, resolve latent value collapsing
- 4. Flow-based
 - 1. Normalizing Flows (NF)
 - 2. Inverse Autoregressive Flows (IAF)

Dirichlet Mixture Model

- 1. Stick Breaking VAE (SB-VAE)
 - Joint distribution : $p_{\theta}(x,\pi) = p_{\theta}(x|\pi)p(\pi) = p_{\theta}(x|\pi)p(v)$ $p_{\theta}(x|\pi) = Ber(x|\mu_{x}(\pi);\theta) \quad or \quad N(x|\mu_{x}(\pi),\sigma_{x}^{2}(\pi)I;\theta)$ $f(x) = \begin{cases} v_{1} & \text{if } k = 1 \\ v_{k} \prod_{i < k} (1 v_{i}) & \text{if } k > 1 \end{cases} \text{ where } v_{k} \sim Beta(v_{k}|1,\alpha_{0})$
 - Variational distribution : $q_{\phi}(\pi|x) = q_{\phi}(v|x)$

$$\pi_k = \begin{cases} v_1 & \text{if } k = 1 \\ v_k \prod_{j < k} (1 - v_j) & \text{if } k > 1 \end{cases} \text{ where } v_k \sim Kumaraswamy} (v_k | a(x), b(x); \phi) \text{ and } v_K = 1 (\approx Truncation)$$

* Reparameterization: $v_k \approx \left(1 - u^{\frac{1}{b(x)}}\right)^{\frac{1}{a(x)}}$ where $u \sim Uniform(0,1)$

• ELBO

$$L_{ELBO}(X) = E_{q_{\phi}(v|X)}[\log p(x|\pi)] - KL(q_{\phi}(v|x)||p(v))$$

$$\frac{a(x) - 1}{a(x)} \left(-\gamma - \Psi(b(x)) - \frac{1}{b(x)} \right) + \log a(x)b(x) + \log B(1, \alpha_0) - \frac{b(x) - 1}{b(x)} + (\alpha_0 - 1)b(x) \sum_{m=1}^{\infty} \frac{1}{m + a(x)b(x)} B\left(\frac{m}{a(x)}, b(x)\right)$$

Dirichlet Mixture Model

- 2. Dirichlet VAE (Dir-VAE)
 - Joint distribution : $p_{\theta}(x, z) = p_{\theta}(x|z)p(z)$

$$p_{\theta}(x|z) = Ber(x|\mu_{x}(z);\theta) \quad or \quad N(x|\mu_{x}(z),\sigma_{x}^{2}(z)I;\theta)$$

$$p(z) = Dirichlet(\alpha) \quad where \quad \alpha = \left(1 - \frac{1}{K}, \dots, 1 - \frac{1}{K}\right)$$

- Variational distribution : $q_{\phi}(z|x)$ $q_{\phi}(z|x) = Dirichlet(a(x)) \ when \ z_k = \frac{v_k}{\sum_{k'} v_{k'}} \ where \ v_k \sim Gamma(v_k|a(x),1)$ $* \ Reparameterization : v_k \approx \left(ua(x)\Gamma(a(x))\right)^{\frac{1}{a(x)}} \ where \ u \sim Uniform(0,1)$
- ELBO

$$L_{ELBO}(X) = E_{q_{\phi}(v|X)}[\log p(x|\pi)] - KL(q_{\phi}(z|x)||p(z))$$

$$\sum_{k}[\log \Gamma(\alpha_k) - \log \Gamma(a(x)_k) + (a(x)_k - \alpha_k)\Psi(a(x)_k)]$$

Explicit distribution

- 1. Disentanglement
 - 1. Beta-VAE
 - 2. Factor-VAE
 - 3. Beta-TC-VAE
 - 4. HSIC-constrained-VAE
- 2. Gaussian Mixture Model
 - 1. Variational Deep Embedding (VaDE)
 - 2. Gaussian Mixture VAE (GM-VAE)
- 3. Dirichlet Mixture Model
 - 1. Stick Breaking VAE (SB-VAE)
 - 2. Dirichlet VAE (Dir-VAE)
- 4. Flow-based
 - 1. Normalizing Flows (NF)
 - 2. Inverse Autoregressive Flows (IAF)

VAE-based

Restrictive하게 posterior의 form을 미리 정하지 않고, 간 단한 distribution을 여러 차례 transform하는 방식을 택함 으로써 ELBO를 tight하게 만듦.

Flow-based

- 1. Normalizing Flow (NF)
 - $z_K = f_K \circ f_{K-1} \circ \cdots \circ f_1(z_0)$ (ex. $f_k(z_{k-1}) = z_{k-1} + u_k \cdot h_k(w_k^T z_{k-1} + b_k)$)
 - $\log q_K(z_K|x) = \log q_0(z_0|x) \sum_{k=1}^K \log \left| \det \frac{\partial f_k}{\partial z_{k-1}} \right|$ = $\log q_0(z_0|x) - \sum_{k=1}^K \log \left| 1 + u_k^T \cdot h_k' \left(w_k^T z_{k-1} + b_k \right) w_k \right|$
- 2. Inverse Autoregressive Flow (IAF)
 - $z_0 = f_0(\epsilon) = \mu_0(x) + \sigma_0(x) \odot \epsilon$ where $p(\epsilon) = N(0, I_D)$
 - $z_k = f_k(z_{k-1}) = \mu_k(h(x), z_{k-1}) + \sigma_k(h(x), z_{k-1}) \odot z_{k-1}$ where $1 \le k \le K$
 - $\log q_K(z_K|x) = \log p(\epsilon) \sum_{k=0}^K \log \left| \det \frac{\partial f_k}{\partial z_{k-1}} \right|$ = $\sum_{i=1}^D \left[-\frac{1}{2} \log 2\pi - \frac{1}{2} \epsilon_i^2 - \sum_{k=0}^K \log \sigma_{k,i} \right]$

Implicit distribution

- 1. GAN-based
 - 1. Adversarial Autoencoder (AAE)
 - 2. Info-GANs
- 2. Kernel-based
 - 1. Stein Variational Gradient Descent (SVGD)

GAN-based

1. Adversarial Autoencoder (AAE)

$$\begin{split} & \text{1st step}: \max_{\theta, \phi} \mathrm{E}_{\mathbf{z} \sim \mathbf{q}_{\phi}(\mathbf{z}|\mathbf{x})}[\log p_{\theta}(x|z)] \\ & \text{2nd step}: \min_{\phi} \max_{\psi} E_{z \sim p(z)} \big[\log D_{\psi}(z)\big] + E_{z \sim q_{\phi}(z)} \big[\log (1 - D_{\psi}(z))\big] \\ & (q_{\phi}(z) = E_{p(x)}[q(z|x)]) \end{split}$$

- 2. Info-GANs
 - $\min_{G} \max_{D} E_{x \sim p(x)} [\log D(x)] + E_{z \sim p(z), c \sim p(c)} [\log (1 D(G(z, c))] \lambda \cdot I(c; G(z, c))$ $\approx \min_{G, q} \max_{D} E_{x \sim p(x)} [\log D(x)] + E_{z \sim p(z), c \sim p(c)} [\log (1 - D(G(z, c)))] - \lambda \cdot [H(c) + E_{z \sim p(z), c \sim p(c), x \sim G(z, c)} [\log q(c|x)]]$

$$\begin{split} &* \ I \big(c; G(z,c) \big) = H(c) - H(c|G(z,c)) \\ &= H(c) + E_{z \sim p(z), c \sim p(c), x \sim G(z,c)} \left[E_{c' \sim p(c'|x)} [\log p(c'|x)] \right] \\ &= H(c) + E_{z \sim p(z), c \sim p(c), x \sim G(z,c)} \left[KL(p(c'|x) || q(c'|x)) + E_{c' \sim p(c'|x)} [\log q(c'|x)] \right] \\ &\geq H(c) + E_{z \sim p(z), c \sim p(c), x \sim G(z,c), c' \sim p(c'|x)} [\log q(c'|x)] \\ &= H(c) + E_{z \sim p(z), c \sim p(c), x \sim G(z,c)} [\log q(c|x)] \end{split}$$

Implicit distribution

- 1. GAN-based
 - 1. Adversarial Autoencoder (AAE)
 - 2. Info-GANs
- 2. Kernel-based
 - 1. Stein Variational Gradient Descent (SVGD)

Kernel-based

1. Stein Variational Gradient Descent (SVGD) : $T(z) = z + \epsilon \cdot f(z)$ ($z \sim q$ and $T(z) \sim q_{T}$)

** Main theorem

$$\nabla_{\epsilon} KL(q_{[T]}(\cdot)||p(\cdot))\Big|_{\epsilon=0} = -E_{z\sim q}\left[trace\left(A_{p}f(z)\right)\right]$$

** Main algorithm

$$T(z) = z + \epsilon \cdot E_{z' \sim q} \left[A_p k(z, z') \right] \approx z + \frac{1}{n} \sum_{j=1}^{n} \left[\nabla_{z^j} \log p(z^j) k(z, z^j) + \nabla_{z^j} k(z, z^j) \right]$$

** Interpretation as Functional Gradient Descent (FGD)

$$\lim_{\epsilon \to 0} \frac{L(f + \tilde{\epsilon} \cdot g) - L(f)}{\tilde{\epsilon}} \coloneqq \left\langle \nabla_f L(f), g \right\rangle_{H_{k(\cdot, \cdot)}}$$

$$L(f) \coloneqq KL\big(q_{[T]}(\cdot) \| \ p(\cdot)\big) \ \Rightarrow \ \nabla_f L(f) \, \Big|_{f=0} \, (z) = -E_{z \prime \sim q} \big[A_p k(z,z')\big]$$

$$\therefore T(z) = z + \epsilon \cdot f(z) = z - \epsilon \cdot \nabla_f L(f) \Big|_{f=0} (z)$$

- 1. Deep Embedded Clustering (DEC)
- 2. Set Transformer (ST)
- 3. Deep Amortized Clustering (DAC)

- Deep Embedded Clustering (DEC)
 - Using student t's distribution, measure the similarity between embedded point z_i and centroid μ_j $q_{ij} = \frac{\left(1 + \left\|z_i - \mu_j\right\|^2 / \alpha\right)^{-\frac{2}{2}}}{\sum_{j'} \left(1 + \left\|z_i - \mu_{j'}\right\|^2 / \alpha\right)^{-\frac{\alpha+1}{2}}} : Probability of assigning sample i to cluster j$
 - Set the target distribution

$$p_{ij} = \frac{q_{ij}^2 / \sum_i q_{ij}}{\sum_{j'} q_{ij'}^2 / \sum_i q_{ij'}}$$

- 1. Improve cluster purity
- $p_{ij} = \frac{q_{ij}^2/\sum_i q_{ij}}{\sum_{i,j} q_{ij}^2/\sum_i q_{ij}}$ 2. Put more emphasis on data points assigned with high confidence
 - 3. Prevent large clusters from distortion by normalization
- Update the embedding function $f_{\theta}: X \to Z$ and the cluster centroid μ with SGD $Loss = KL(P||Q) = \sum_{i} \sum_{j} p_{ij} \log p_{ij} / q_{ij}$

→ Randomly Initialized Learnable Parameters

- Set Transformer (ST)
 - $X \in \mathbb{R}^{n \times d}$, $Y \in \mathbb{R}^{n \times d}$, $I \in \mathbb{R}^{m \times d}$, $S \in \mathbb{R}^{k \times d}$, $Z = \mathbb{R}^{n \times d}$
 - Operations & Blocks
 - rFF: row wise feedforward layer
 - $MAB(X,Y) = LayerNorm(H + rFF(H)) \in R^{n \times d}$ where H = LayerNorm(X + MultiHead(X,Y,Y))
 - $SAB(X) = MAB(X,X) \in \mathbb{R}^{n \times d}$
 - $ISAB_m(X) = MAB(X, H) \in R^{n \times d}$ where $H = MAB(I, X) \in R^{m \times d}$
 - $PMA_k(Z) = MAB(S, rFF(Z)) \in R^{k \times d}$
 - $Encoder(X) = SAB(SAB(X)) \in \mathbb{R}^{n \times d} \text{ or } ISAB_m(ISAB_m(X)) \in \mathbb{R}^{n \times d}$
 - $Decoder(Z) = rFF(SAB(PMA_k(Z))) \in R^{k \times d}$
 - ** Main theorem

Set Transformer is a universal approximator of permutation invariant functions.

** Amortized Clustering with Mixture of Gaussians

$$\max E_X \left| \sum_{i=1}^{|X|} \log \sum_{j=1}^k \pi_j(X) N\left(x_i; \mu_j(X), diag\left(\sigma_j^2(X)\right)\right) \right| \quad where \left\{\pi_j(X), \mu_j(X), \log \sigma_j^2(X)\right\}_{j=1}^k \text{ is output }$$

- 3. Deep Amortized Clustering (DAC)
 - ST + Filtering
 - 1. Minimum Loss Filtering

$$L(x, y, m, \theta) = \min_{j \in \{1, \dots, k_X\}} \left(\frac{1}{n_X} \sum_{i=1}^{n_X} BCE(m_i, I(y_i = j)) - \frac{1}{n_{X|j}} \sum_{i|y_i = j} \log p(x_i; \theta) \right)$$

encode data: $H_X = ISAB_L(X),$ decode cluster: $H_{\theta} = PMA_1(H_X),$ $\theta = rFF(H_{\theta}),$ decode mask: $H_{\mathfrak{m}} = ISAB_{L'}(MAB(H_X, H_{\theta})),$ $\mathfrak{m} = \operatorname{sigmoid}(rFF(H_{\mathfrak{m}}))$

2. Anchored Filtering

$$L(x, y, a, m, \theta) = \frac{1}{n_X} \sum_{i=1}^{n_X} BCE(m_i, I(y_i = j_a)) - \frac{1}{n_{X|j_a}} \sum_{i|y_i = j_a} \log p(x_i; \theta)$$

encode data: $H_X = ISAB_L(X),$ $H_{X|a} = MAB(H_X, h_a),$ decode cluster: $H_{\theta} = PMA_1(H_{X|a}),$ $\theta = rFF(H_{\theta}),$ decode mask: $H_{\mathfrak{m}} = ISAB_{L'}(MAB(H_{X|a}, H_{\theta})),$ $\mathfrak{m} = sigmoid(rFF(H_{\mathfrak{m}}))$

Evaluation Metrics in BNN

- Fidelity of posterior approximation
 - $\widehat{y_n}^{high}$ and $\widehat{y_n}^{low}$ are 97.5% and 2.5% percentile, respectively
 - 1. Average Marginal Log-likelihood (higher the better) : $E_{(x_n,y_n)\sim D}\left[E_{q(w)}[p(y_n|x_n,w)]\right]$
 - 2. Predictive RMSE (lower the better): $\sqrt{\frac{1}{N}\sum_{n=1}^{N} ||y_n E_{q(w)}[fx_n, w)]||_2^2}$
 - 3. Prediction Interval Coverage Probability (PICP) (higher the better) : $\frac{1}{N}\sum_{n=1}^{N}I\left[y_{n}\leq\widehat{y_{n}}^{high}\right]\cdot I\left[y_{n}\geq\widehat{y_{n}}^{low}\right]$
 - 4. Mean Prediction Interval Width (MPIW) (lower the better) : $\frac{1}{N}\sum_{n=1}^{N}(\widehat{y_n}^{high}-\widehat{y_n}^{low})$
- Uncertainty Calibration
 - 1. Reliability diagram : $p(correct | confidence = \rho) \forall \rho \in [0,1]$
 - 2. Expected Calibration Error (ECE) (lower the better) : $ECE = E_{confidence}[|p(correct|confidence) confidence)|]$